

N-Channel 60 V (D-S) MOSFET

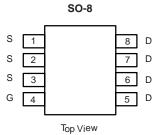
PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^d	Q _g (Typ.)			
60	0.010 at V _{GS} = 10 V	12	10.5 nC			
	0.015 at V _{GS} = 4.5 V	12				

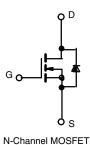
FEATURES DT-Trench Power MOSFET 100 % R_g and UIS tested

Ro HS

APPLICATIONS

- DC/DC converters
- Power supplies
- Motor drive control
- Battery and load switch





PARAMETER Drain-source voltage Gate-source voltage		SYMBOL	LIMIT	V
		V _{DS}	60	
		V _{GS}	± 20	
	T _C = 25 °C		12	
Continuous drain august (T. 150 °C)	T _C = 70 °C	1 , [9.2	
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	l _D	8.8 ^{a, b}	
	T _A = 70 °C		6.3 ^{a, b}	
Pulsed drain current (t = 100 μs)		I _{DM}	48	A
Continuous source-drain diode current	T _C = 25 °C		12	
	T _A = 25 °C	l _s	2.5 ^{a, b}	
Single pulse avalanche current Single pulse avalanche energy L = 0.1 mH		I _{AS}	45	
		E _{AS}	65	mJ
	T _C = 25 °C		5.9	
Manipular and a second disciplation	T _C = 70 °C		3.8	14/
Maximum power dissipation	T _A = 25 °C	P _D	2.7 ^{a, b}	W
	T _A = 70 °C		1.9 ^{a, b}	
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	90
Soldering recommendations (peak tempera	ture) ^c		260	°C

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum junction-to-ambient ^a	t ≤ 10 s	R _{thJA}	32	50	°C/W		
Maximum junction-to-foot (drain)	Steady state	R_{thJF}	20	28	C/VV		

Notes

- a. Surface mounted on 1" x 1" FR4 board
- b. t = 10 s
- c. Maximum under steady state conditions is 85 $^{\circ}\text{C/W}$



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static					•		
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	L 050 A	-	33	-	m\//°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-4.8	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	-	3	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	100	nA	
Zana anta valta na dunin annuant	I _{DSS}	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}$			1		
Zero gate voltage drain current		V _{DS} = 48 V, V _{GS} = 0 V, T _J = 70 °C	-	-	10	μA	
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	12	-	-		
Duning and the seriet and 2	_	V _{GS} =10 V, I _D = 10 A	-	0.0100	0.0130		
Drain-source on-state resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	-	0.0150	0.0190	Ω	
Forward transconductance a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_D = 10 \text{ A}$	-	39	-	S	
Dynamic ^b					•		
Input capacitance	C _{iss}		-	1090	-	pF	
Output capacitance	C _{oss}	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	530	-		
Reverse transfer capacitance	C _{rss}		-	25	-		
Tatal asta shaws	0	V _{DS} = 48 V, V _{GS} = 10 V, I _D = 5 A	- 10.5	10.5	-	nC	
Total gate charge	Q_g	-	-	5.2	8		
Gate-source charge	Q _{gs}	$V_{DS} = 48 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	-	2.2	-		
Gate-drain charge	Q _{gd}		-	1.1	-		
Gate resistance	R _g	f = 1 MHz	-	3	-	Ω	
Turn-on delay time	t _{d(on)}		-	7	15		
Rise time	t _r	$V_{DD} = 48 \text{ V}, R_L = 6 \Omega, I_D \cong 5 \text{ A},$	-	21	40	1	
Turn-off delay time	t _{d(off)}	V_{GEN} = 10 V, R_g = 1 Ω	-	10	20		
Fall time	t _f		-	10	20		
Turn-on delay time	t _{d(on)}		-	13	25	- ns - -	
Rise time	t _r	$V_{DD} = 48 \text{ V}, R_L = 6 \Omega, I_D \cong 5 \text{ A},$	-	25	50		
Turn-off delay time	t _{d(off)}	V_{GEN} = 4.5 V, R_g = 1 Ω	-	10	20		
Fall time	t _f		-	22	45		
Drain-Source Body Diode Characterist	ics						
Continuous source-drain diode current	Is	T _C = 25 °C	-	-	12	^	
Pulse diode forward current	I _{SM}		-	-	48	A	
Body diode voltage	V _{SD}	$I_{S} = 5 \text{ A}, V_{GS} = 0 \text{ V}$	-	0.70	1.2	V	
Body diode reverse recovery time	t _{rr}		-	30	60	ns	
Body diode reverse recovery charge	Q _{rr}	L 5 A 31/44 100 A / - T 05 00	-	60	120	nC	
Reverse recovery fall time	ta	$I_F = 5 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$	-	15	-		
Reverse recovery rise time	t _b	t _b		15	-	ns	

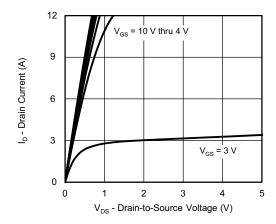
Notes

- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

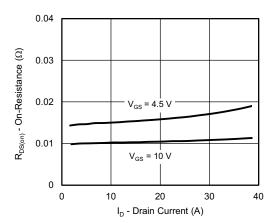
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



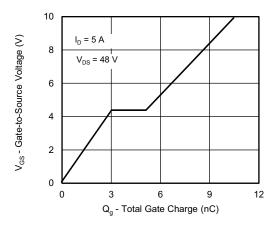
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



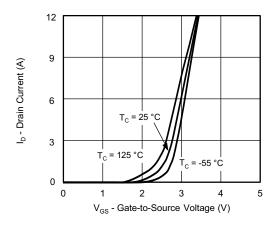
Output Characteristics



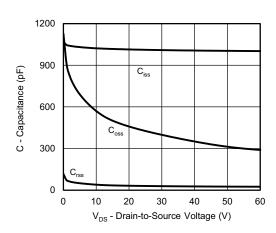
On-Resistance vs. Drain Current and Gate Voltage



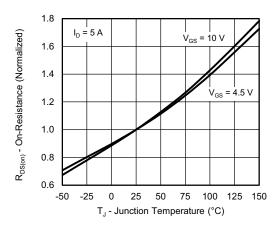
Gate Charge



Transfer Characteristics



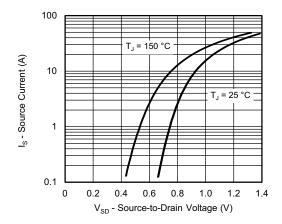
Capacitance



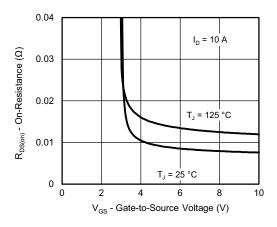
On-Resistance vs. Junction Temperature



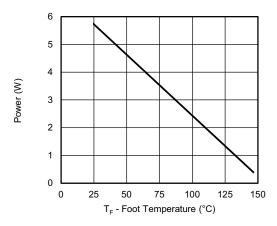
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



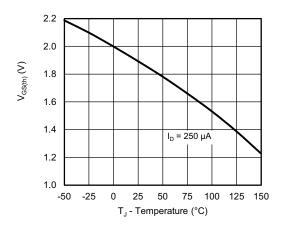
Source-Drain Diode Forward Voltage



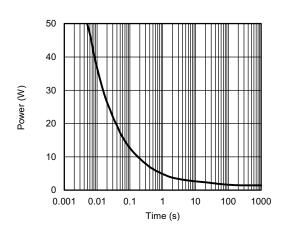
On-Resistance vs. Gate-to-Source Voltage



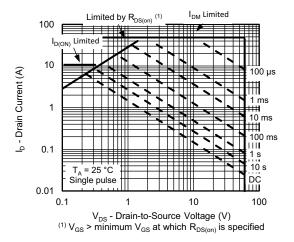
Power, Junction-to-Foot



Threshold Voltage



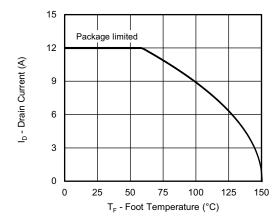
Single Pulse Power, Junction-to-Ambient



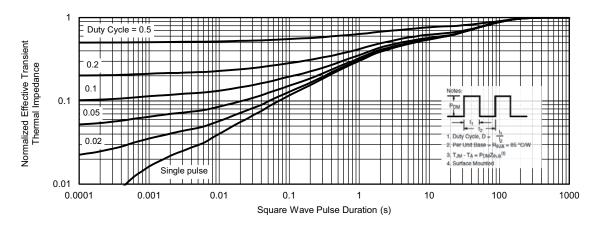
Safe Operating Area, Junction-to-Ambient



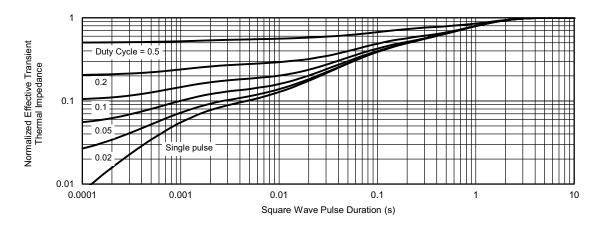
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating ^a



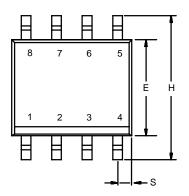
Normalized Thermal Transient Impedance, Junction-to-Ambient

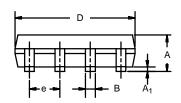


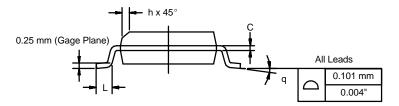
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







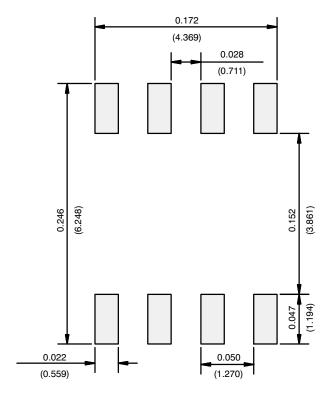
	MILLIM	IETERS	S INCHES		
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27	BSC	0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
FCN: C-06527-Rev I 11-Sen-06					

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)





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